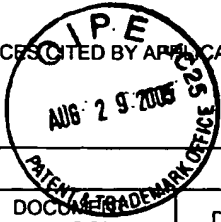


SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 250752US2S		SERIAL NO. 10/803,967	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hideki TAKAHASHI			
				FILING DATE March 19, 2004		GROUP 2655	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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	AK						
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	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
fsg	AO	2002-0007298	1/26/2002	Korea (with corresponding JP 2000-293948)			X
	AP	2000-293948	10/20/2000	Japan			X
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>Rob</i>					Date Considered 12/5/06		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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				FILING DATE March 19, 2004		GROUP 2655	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	9-320204	12/12/1997	JAPAN			X
	AP	10-83658	03/31/1998	JAPAN			X
	AQ	2001-291367	10/19/2001	JAPAN			X
	AR	2002-288938	10/04/2002	JAPAN			X
	AS	2000-149256	05/30/2000	JAPAN			X
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner		Date Considered					
Examiner: <i>Ps</i>		Date Considered: 12/5/06					

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 250752US2S		SERIAL NO. 10/803,967	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hideki TAKAHASHI			
				FILING DATE March 19, 2004		GROUP 2655	
				U.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	AA						
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	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	9-213011	08/15/1997	JAPAN			X
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	Standard ECMA-272, 2 nd Edition, pages 34 (16.2 Lead-in Zone)-52 (17.8 Formatting of the disk), June 1999					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>P. H.</i>				Date Considered <i>12/5/04</i>			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							